Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/534,315	SCHEFFLER ET AL.		
Examiner	Art Unit		
John R. Hardee	1751		

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EIC structure search PALM inventor search	10/30/2006	JRH		
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